

**Search Notes**

Application/Control No.

10/537,940

Examiner

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Applicant(s)/Patent under  
Reexamination

HAASE ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	180	11/10/2006	JMN
564	168	11/10/2006	JMN
549	268	11/10/2006	JMN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (Registry/Caplus), printout attached	11/10/2006	JMN
Inventor Search Reviewed for Double Patenting	11/10/2006	JMN
Abstract, Oath, Spec, Priority Papers, International Search Report reviewed	11/10/2006	JMN